

<b>Notice of References Cited</b>	Application/Control No. 10/048,169	Applicant(s)/Patent Under Reexamination SEITZ, MICHAEL WALTER	
	Examiner Darren W Gorman	Art Unit 3752	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,749,176	06-1956	Steyer, Friedrich	239/80
	B	US-3,798,411	03-1974	Wagner, Jaromir	219/136
	C	US-3,901,441	08-1975	Kasagi, Ryoichi	239/81
	D	US-4,492,337	01-1985	Harrington et al.	239/81
	E	US-4,528,782	07-1985	Bean, George	451/102
	F	US-5,191,186	03-1993	Crapo et al.	219/76.16
	G	US-5,213,848	05-1993	Zurecki et al.	427/449
	H	US-5,468,295	11-1995	Marantz et al.	118/723DC
	I	US-5,927,604	07-1999	Laidler, Kevin O.	239/104
	J	US-5,932,293	08-1999	Belashchenko et al.	427/446
	K	US-5,964,405	10-1999	Benary et al.	239/84
	L	US-6,245,390	06-2001	Baranovski et al.	427/449
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.